Search Notes

Application/Control No.	Applicant(s)/Patent und Reexamination	er
10/519,230	TAKAI, SEIICHIRO	
Examiner	Art Unit	
Dean J. Kramer	3652	

	SEAR	CHED	
Class	Subclass	Date	Examiner
294	74 75 82.21 82.24 82.31 82.32 82.33	5/30/2008	DJK
294	82.34	5/30/2008	DJK

INT	NTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

SEARCH (INCLUDING SEAR	SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR	